

IN THE CLAIMS+

Please amend the claims as follows:

Claim 1 (Currently Amended): A CMOS image sensor comprising:

a plurality of unit cells arranged in the row and column directions at predetermined pitches of ~~[[ph0]]~~ and ~~[[pv0]]~~ Ph0 and Pv0, respectively, in a two-dimensional ~~plain~~ plane forming a matrix, each of the unit cells including:

a first and a second photoelectric conversion element, each of which corresponds to a pixel,

a first and a second transfer transistor for transferring charges stored by the first and second photoelectric conversion elements to their common floating junction,

a reset transistor for resetting the potential of the floating junction,

a driver transistor whose output potential is controlled by the potential of the floating junction, and

an address transistor for selectively driving the driver transistor;

reset drain voltage lines provided in the column direction of the matrix arrangement for resetting the potential of ~~[[the]]~~ common floating junctions included in the unit ~~cell~~ cells belonging to each column of the matrix arrangement;

first transfer lines provided in the row direction of the matrix arrangement for controlling ~~[[the]]~~ first transfer ~~transistor~~ transistors included in the unit ~~cell~~ cells belonging to each row;

second transfer lines in the row direction of the matrix arrangement for controlling ~~[[the]]~~ second transfer transistors included in the unit cells belonging to each row of the matrix arrangement;

signal output lines provided in the column direction of the matrix arrangement to which ~~[[the]]~~ output voltages of ~~[[the]]~~ driver transistors included in the unit cells belonging to each column of the matrix arrangement are supplied, and

address lines provided in the row direction of the matrix arrangement for selectively driving the driver transistors included in the unit ~~cell~~ cells belonging to each row, wherein

first photoelectric conversion elements constituting the receptive unit cells and arranged in a horizontal row form a first pixel line,

second photoelectric conversion elements constituting the respective unit cells and arranged in a horizontal row form a second pixel line adjacent to the first pixel line, and

the first photoelectric conversion elements arranged in the first pixel lines are dislocated from the respective closest ones of the second photoelectric conversion elements arranged in the second pixel lines by $Ph0/2$ and $Pv0/2$ in the horizontal and vertical directions, respectively, to form a checker wise arrangement as a whole

~~the first and the second photoelectric conversion elements are spaced by $ph0/2$ and $pv0/2$ to each other in the horizontal and vertical directions, thereby being arranged in an oblique direction in relation to the row or column directions of the matrix, and~~

~~the first and the second transfer transistors, the floating junction, the reset transistor, the driver transistor or the address transistor included in each of the unit cells are placed in areas surrounded by adjacent unit cells.~~

Claim 2 (Currently Amended): A CMOS image sensor according to claim 1, wherein ~~[[a]]~~ the first pixel line lines composed of the first photoelectric conversion ~~element~~ elements included in the unit cells belonging to each row of the matrix arrangement and ~~[[a]]~~ the second pixel lines composed of the second photoelectric conversion ~~element~~ elements

included in the unit cells are independently read respectively by the first and second transfer lines.

Claim 3 (Original): A CMOS image sensor according to claim 2, wherein the first pixel lines and the second pixel lines are read by switching the first and second transfer transistors by the first and second transfer lines.

Claim 4 (Original): A CMOS image sensor according to claim 3, wherein the driver transistors and the address transistors which are included in the respective unit cells are connected in series, wherein the first and second photoelectric conversion elements are connected to gate electrodes of the driver transistors via the first and second transfer transistors, and wherein source electrodes of the reset transistors are connected to the gate electrodes of the driver transistors.

Claim 5 (Currently Amended): A CMOS image sensor according to claim 4, wherein the first and second photoelectric conversion element ~~elements are~~ photodiodes included in the unit cells are spaced by Ph0/2 and Pv0/2 in the horizontal and vertical directions from each other and are formed in a rectangle shape inclined by 45 degrees.

Claim 6 (Canceled).

Claim 7 (Currently Amended): A CMOS image sensor according to claim 5, wherein the unit cells are formed as an integrated circuit on a semiconductor substrate and the first and second photoelectric conversion element photodiodes of each unit cell arranged in the oblique direction share the floating junction area, the reset drain area, the reset transistors, the

driver transistors, the address transistors, the junction area between the driver transistors and the address transistors and the diffusion area at the connecting portion between the driver transistors and the signal output line, thereby reading signals of the first pixel row and the second pixel row independently.

Claim 8 (Currently Amended): A CMOS image sensor comprising:

a plurality of unit cells arranged in the row and column directions at a predetermined pitch of $[[ph0]]$ Ph0 and $[[pv0]]$ Pv0, respectively, in a two-dimensional ~~plain~~ plane forming a matrix, each of the unit cells including:

a first and a second photoelectric conversion element, each of which corresponds to a pixel,

a first and a second transfer transistor for transferring charges stored by the first and the second photoelectric conversion elements to their common floating junction junctions,

a reset transistor for resetting the potential of the floating junction,

a driver transistor whose output potential is controlled by the potential of the floating junction, and

an address transistor for selectively driving the driver transistor;

reset drain voltage lines provided in the column direction of the matrix arrangement for resetting the potential of $[[the]]$ common floating junctions included in the unit cells ~~cell~~ belonging to each column of the matrix arrangement;

first transfer lines provided in the row direction of the matrix arrangement for controlling $[[the]]$ first transfer transistors ~~transistor~~ included in the unit cells ~~cell~~ belonging to each row;

second transfer lines in the row direction of the matrix arrangement for controlling
[[the]] second transfer transistors included in the unit cells belonging to each row of the
matrix arrangement;

first signal output lines provided in the column direction of the matrix arrangement to
which [[the]] output voltages of [[the]] driver transistors included in the unit cells arranged in
the odd numbered rows are supplied;

second signal output lines provided in the column direction of the matrix arrangement
to which the output voltages of the driver transistors included in the unit cells arranged in the
even numbered rows are supplied; and

address lines provided in the row direction of the matrix arrangement for selectively
driving the driver transistors included in the unit cell belonging to each row, wherein

~~the first and the second photoelectric conversion elements are spaced by $\phi_0/2$ and $\phi_v/2$ to each other in the horizontal and vertical directions, thereby being arranged in an oblique direction in relation to the row or column directions of the matrix,~~

~~the first and the second transfer transistors, the floating junction, the reset transistor,
the driver transistor or the address transistor included in each of the unit cells are placed in
areas surrounded by adjacent unit cells, and~~

image signals of the pixel arrays composed of the photoelectric conversion elements
included in the unit cells arranged in the neighboring two columns are read simultaneously
using the first and second signal output lines,

first photoelectric conversion elements constituting the respective unit cells and
arranged in a horizontal row form a first pixel line,

second photoelectric conversion elements constituting the respective unit cells and
arranged in a horizontal row form a second pixel line adjacent to the first pixel line, and

the first photoelectric conversion elements arranged in the first pixel lines are dislocated from the respective closest ones of the second photoelectric conversion elements arranged in the second pixel lines by $Ph0/2$ and $Pv0/2$ in the horizontal and vertical directions, respectively, to form a checker wise arrangement as a whole.

Claim 9 (Currently Amended): A CMOS image sensor according to claim 8, wherein [[the]] adjacent pixel lines, which are read simultaneously, are a pixel row formed by the second photoelectric conversion elements included in [[the]] unit ~~cell~~ cells belonging to [[the]] a first row and a pixel row formed by the first photoelectric conversion ~~element~~ elements included in [[the]] unit ~~cell~~ cells belonging to [[the]] a second row, thereby ~~simultaneously read the image signals of the pixel~~ pixels of adjacent [[tow]] two rows are simultaneously read into [[the]] first and second signal output lines by respectively supplying the same transfer pulse to [[the]] a second transfer line provided for the unit ~~cell~~ cells belonging to the first row and [[the]] a first transfer line provided for the unit ~~cell~~ cells belonging to the second row.

Claim 10 (Currently Amended): A CMOS image sensor according to claim 9, a gate of [[the]] a second transfer transistor included in [[the]] a unit cell ~~belong~~ belonging to the first row and a gate of [[the]] a first transfer transistor included in [[the]] a unit cell ~~belong~~ belonging to the second row are connected to each other.

Claim 11 (Currently Amended): A CMOS image sensor according to claim 10, wherein [[the]] a first pixel row composed of the first photoelectric conversion elements ~~element~~ included in the unit cells belonging to the respective rows of the matrix arrangement and [[the]] a second pixel row composed of the second photoelectric conversion elements

~~element~~ included in the unit cells are independently read respectively by the first and second transfer lines.

Claim 12 (Original): A CMOS image sensor according to claim 11, wherein the first pixel row and the second pixel row are read by switching first and second transfer transistors by the first and second transfer lines.

Claim 13 (Original): A CMOS image sensor according to claim 12, wherein the driver transistors and the address transistors, which are included in the unit cells are connected in series, wherein the first and second photoelectric conversion elements are connected to gate electrodes of the driver transistors via the first and second transfer transistors, and wherein source electrodes of the reset transistors are connected to the gate electrodes of the driver transistors.

Claim 14 (Currently Amended): A CMOS image sensor according to claim 13, wherein the first and second photoelectric conversion elements ~~are photodiodes~~ included in each of the unit cells are spaced by $Ph0/2$ and $Pv0/2$ in the horizontal and vertical directions, respectively, from each other and are formed in a rectangular shape inclined by 45 degrees.

Claim 15 (Canceled).

Claim 16 (Currently Amended): A CMOS image sensor according to claim 14, wherein the unit cells are formed as an integrated circuit on a semiconductor substrate and wherein the first and second photoelectric conversion elements ~~photodiodes~~ in each unit cell arranged in the oblique direction share the floating junction area, the reset drain area, the

reset transistors, the driver transistors, the address transistors, the junction area between the driver transistors and the address transistors, and the diffusion area at the connecting portion between the driver transistors and the signal output line,

thereby reading signals of the first pixel row and the second pixel row independently.

Claim 17 (Original): A CMOS image sensor according to claim 1, wherein among unit cells arranged in adjacent two rows of the matrix arrangement, a gate of the address transistor included in the unit cell arranged in the first row and a gate of the reset transistor included in the unit cell arranged in the second row are connected, and while an image signal from the second photoelectric conversion element included in the unit arranged in the first row is being read, the floating junction included in the unit cell arranged in the second row to be read next is reset, thus an image signal from the first photoelectric conversion element included in the unit cell arranged in the second row can be read.

Claim 18 (Original): A CMOS image sensor according to claim 17, wherein a first pixel row composed of the first photoelectric conversion element included in the unit cell belonging to each row of the matrix arrangement and a second pixel row composed of the second photoelectric conversion element included in the unit cell are independently read by the first and second transfer lines.

Claim 19 (Original): A CMOS image sensor according to claim 18, wherein the first pixel row and the second pixel row are read by switching the first and second transfer transistors by the first and second transfer lines.

Claim 20 (Original): A CMOS image sensor according to claim 19, wherein the driver transistors and the address transistors which are included in the unit cells are connected in series, and the first and second photoelectric conversion elements are connected to gate electrodes of the driver transistors via the first and second transfer transistors, and source electrodes of the reset transistors are connected to the gate electrodes of the driver transistors.

Claim 21 (Currently Amended): A CMOS image sensor according to claim 19, wherein the first and second photoelectric conversion elements ~~are photodiodes~~ included in each unit cell are spaced by $Ph0/2$ and $Pv0/2$ in the horizontal and vertical directions, respectively, from each other and are formed in a rectangular shape inclined by 45 degrees.

Claim 22 (Canceled).

Claim 23 (Original): A CMOS image sensor according to claim 21, wherein unit cells are formed as an integrated circuit on a semiconductor substrate and the first and second photodiodes arranged in the oblique direction share the floating junction area, the reset drain area, the reset transistors, the driver transistors, the address transistors, the junction area between the driver transistors and the address transistors and the diffusion area at the connecting portion between the driver transistors and the signal output line, thereby read signals of the first pixel row and the second pixel row independently.